

# SOT-23-6L Plastic-Encapsulate MOSFETS

## WCM2068-6

N- and P-Channel Complementary, 20V, MOSFET

### Features

- Trench Technology
- Super high density cell design
- Excellent ON resistance
- Extremely Low Threshold Voltage
- Small package SOT-23-6L

### Applications

- Driver: Relays, Solenoids, Lamps, Hammers
- Power supply converters circuit
- Load/Power Switching for portable device

Marking: 31C

### Descriptions

The WCM2068 is the N-Channel and P-Channel enhancement MOS Field Effect Transistor as a single package for DC-DC converter or level shift applications, uses advanced trench technology and design to provide excellent RDS(ON) with low gate charge. Standard Product WCM2068 is Pb-free and Halogen-free.

### Maximum Ratings (T<sub>A</sub>=25°C unless otherwise specified)

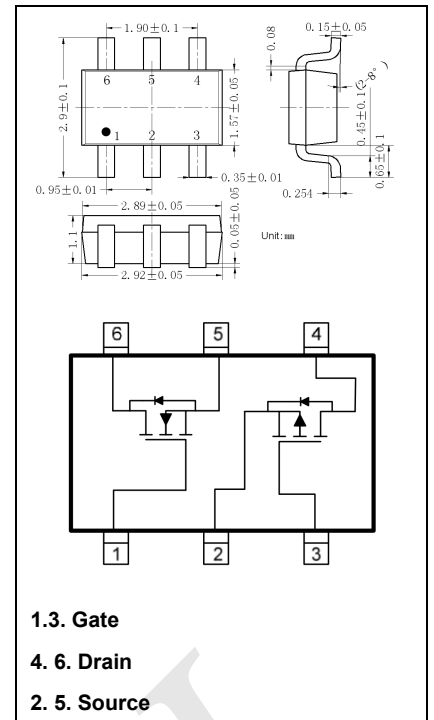
Symbol	Parameter	N-Channel	P-Channel	Unit	
V <sub>DSS</sub>	Drain-Source voltage	20	-20	V	
V <sub>GSS</sub>	Gate-Source voltage	±8	±8		
I <sub>D</sub>	Continuous Drain Current <sup>1, 4)</sup>	T <sub>A</sub> = 25°C	4.4	-2.8	A
		T <sub>A</sub> = 70°C	3.5	-2.2	
I <sub>DM</sub>	Pulsed Drain Current <sup>3)</sup>	16	-10	A	
P <sub>D</sub>	Power Dissipation <sup>1, 4)</sup>	T <sub>A</sub> = 25°C	0.72		W
		T <sub>A</sub> = 70°C	0.46		
T <sub>J</sub>	Operation junction temperature	-55 ~ +150		°C	
T <sub>stg</sub>	Storage temperature range	-55 ~ +150		°C	

### Thermal Resistance Ratings (T<sub>A</sub>=25°C unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	
R <sub>θJA</sub>	Junction-to-Ambient Thermal Resistance <sup>1)</sup>	t ≤ 10s	74	92	°C/W
		Steady State	115	143	
R <sub>θJA</sub>	Junction-to-Ambient Thermal Resistance <sup>2)</sup>	t ≤ 10s	90	112	°C/W
		Steady State	138	172	
R <sub>θJC</sub>	Junction-to-Case Thermal Resistance	Steady State	63	78	°C/W

### Notes

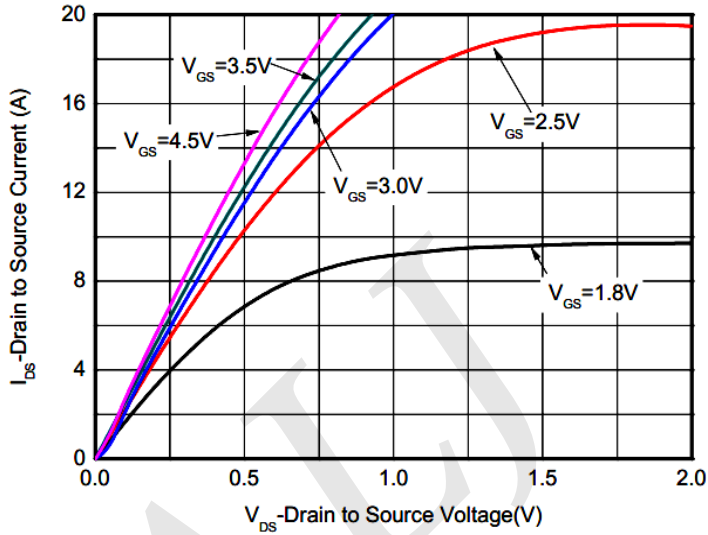
1. Surface mounted on FR4 Board using 1 square inch pad size, 1oz copper
2. Surface mounted on FR4 board using minimum pad size, 1oz copper
3. Pulse width < 380μs, Duty Cycle < 2%
4. Maximum junction temperature T<sub>J</sub> = 150°C. d. 1.6 mm from case.



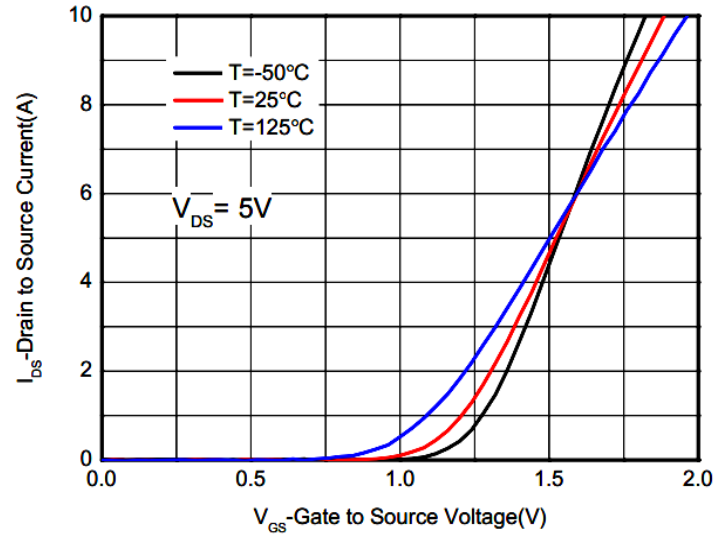
**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise specified)**

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit		
<b>Off Characteristics</b>								
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	N-Ch	20		V		
		V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA	P-Ch	-20				
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V	N-Ch		1	μA		
		V <sub>DS</sub> = -16V, V <sub>GS</sub> = 0V	P-Ch		-1			
I <sub>GSS</sub>	Gate-body Leakage current	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±8V			±1	μA		
<b>ON Characteristics</b>								
V <sub>GS(th)</sub>	Gate-Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	N-Ch		0.65	1.0	V	
		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA	P-Ch		-0.70	-1.0		
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3.4A	N-Ch		33	46	mΩ	
		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -2.8A	P-Ch		85	116		
		V <sub>GS</sub> = 3.3V, I <sub>D</sub> = 3.0A	N-Ch		37	55		
		V <sub>GS</sub> = -3.3V, I <sub>D</sub> = -2.0A	P-Ch		100	125		
		V <sub>GS</sub> = 2.5V, I <sub>D</sub> = 3.0A	N-Ch		41	69		
		V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -2.0A	P-Ch		110	131		
<b>Dynamic Characteristics</b>								
C <sub>iss</sub>	Input Capacitance	N-mos: V <sub>DS</sub> = 10V, V <sub>GS</sub> = 0V, f = 1MHz	N-Ch		345	pF		
C <sub>oss</sub>	Output Capacitance		P-Ch		531			
		C <sub>rss</sub>	Reverse Transfer Capacitance	P-mos: V <sub>DS</sub> = -10V, V <sub>GS</sub> = 0V, f = 1MHz	N-Ch			55
P-Ch					61			
Q <sub>g(tot)</sub>	Total Gate Charge	N-mos: V <sub>DD</sub> = 10V, V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3.4A	N-Ch		5.25		nC	
			P-Ch		5.8			
Q <sub>g(th)</sub>	Threshold gate charge		N-Ch		0.65			
			P-Ch		0.72			
Q <sub>gs</sub>	Gate-Source Charge		P-mos: V <sub>DD</sub> = -10V, V <sub>GS</sub> = -4.5V I <sub>D</sub> = -2.8A	N-Ch		1.2		
				P-Ch		1.1		
Q <sub>gd</sub>	Gate-Drain Charge	N-Ch			1.05			
		P-Ch			1.0			
t <sub>d(on)</sub>	Turn-On Delay Time	N-mos: V <sub>DD</sub> = 10V, V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 1.0A, R <sub>G</sub> = 6Ω		N-Ch		18.6	ns	
				P-Ch		21.6		
t <sub>r</sub>	Rise Time		N-Ch		8.2			
			P-Ch		8.6			
t <sub>d(off)</sub>	Turn-Off Delay Time		P-mos: V <sub>DD</sub> = -10V, I <sub>D</sub> = -1.2A, V <sub>GS</sub> = -4.5V, R <sub>G</sub> = 6Ω	N-Ch		55		
				P-Ch		58		
t <sub>f</sub>	Fall Time	N-Ch			7.6			
		P-Ch			8.4			
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 1.0A		N-Ch		0.7	1.5	V
		V <sub>GS</sub> = 0V, I <sub>S</sub> = -1.0A		P-Ch		-0.8	-1.5	

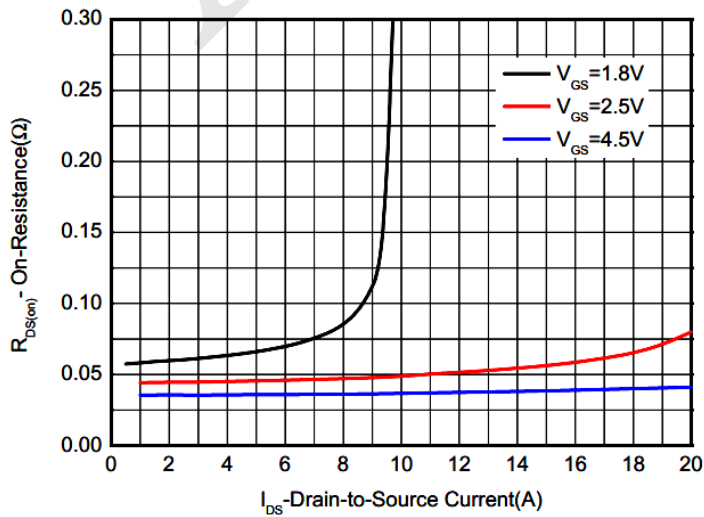
# N-Channel Typical Characteristics



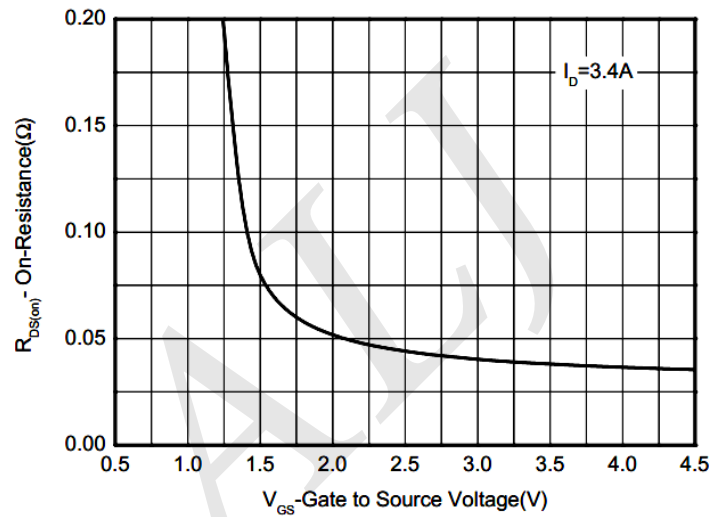
**Output Characteristics**



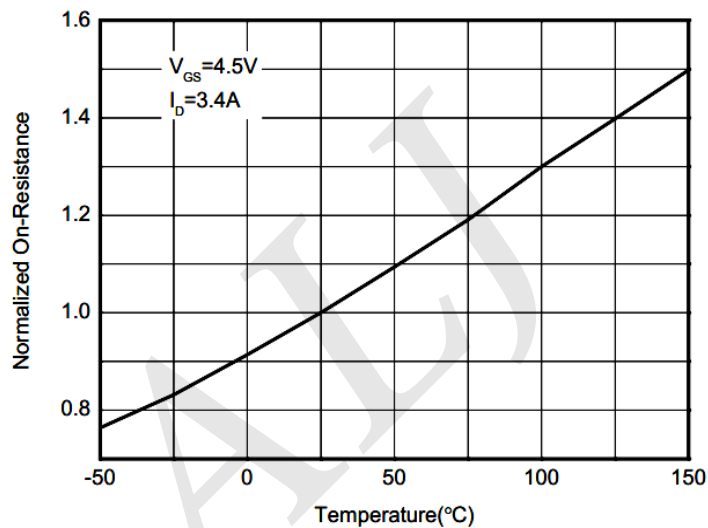
**Transfer Characteristics**



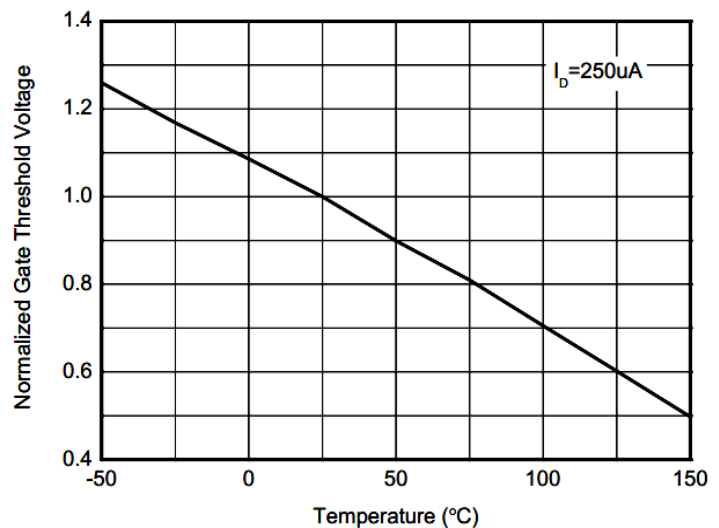
**On-Resistance vs. Drain Current**



**On-Resistance vs. Gate-to-Source Voltage**

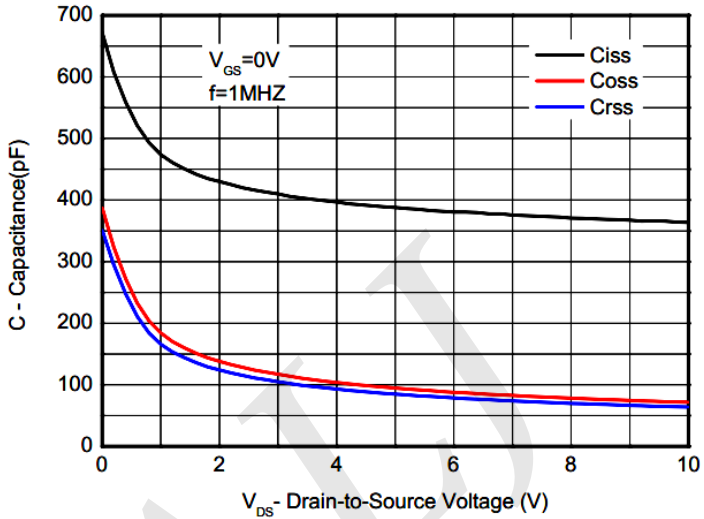


**On-Resistance vs. Junction Temperature**

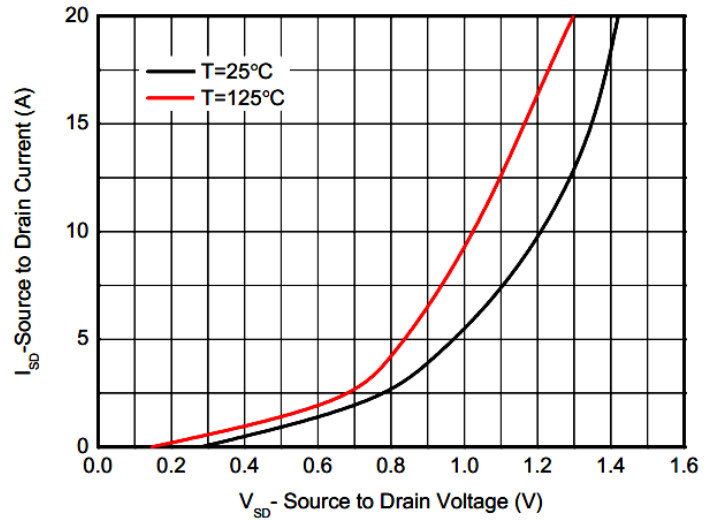


**Threshold Voltage vs. Temperature**

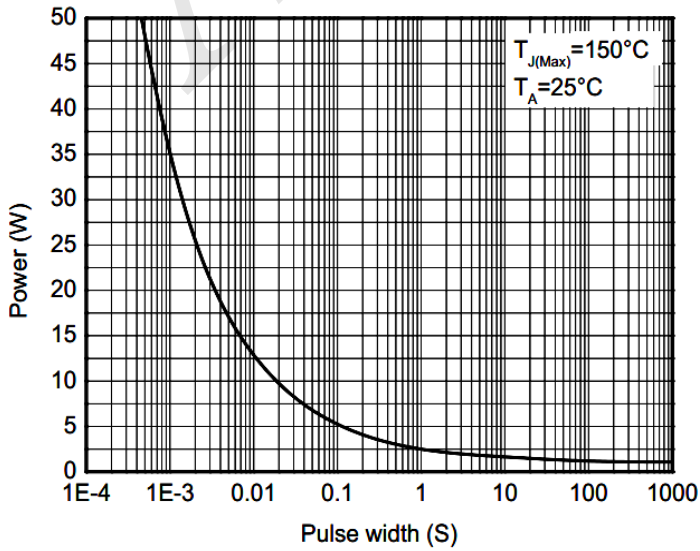
# N-Channel Typical Characteristics (Cont.)



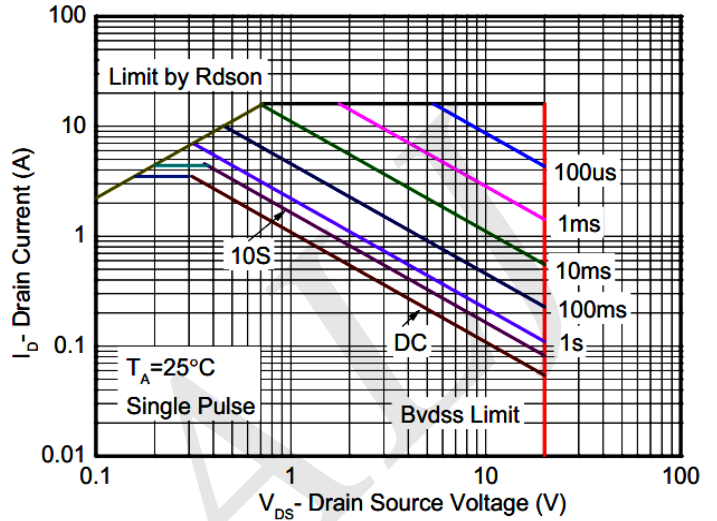
**Capacitance**



**Body Diode Forward Voltage**

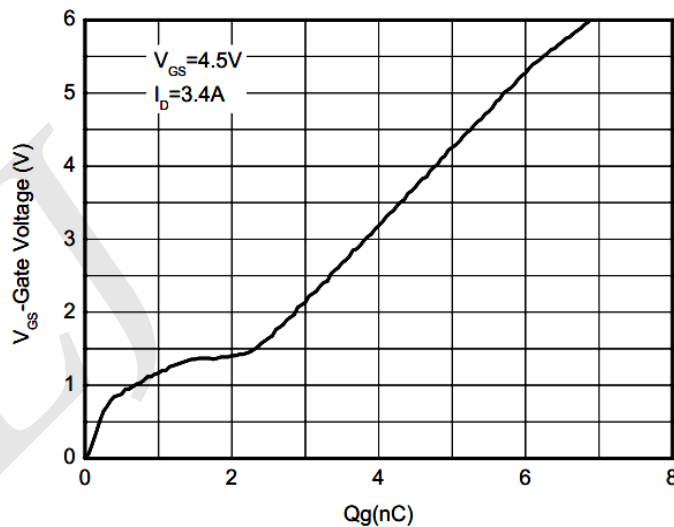


**Single pulse power**



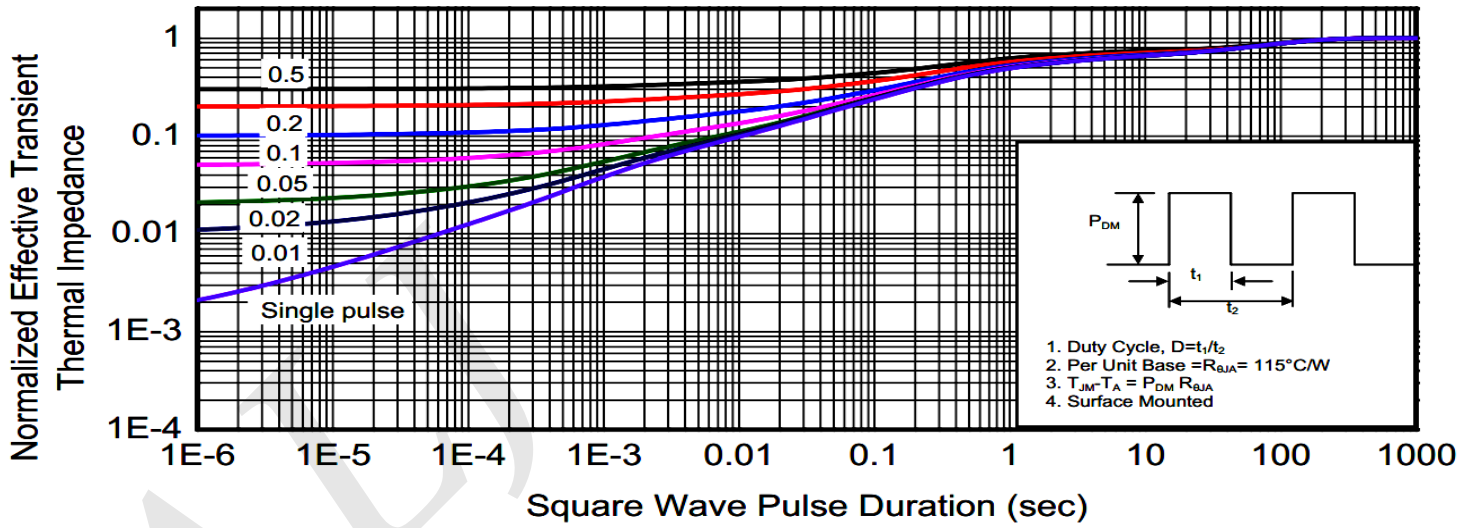
\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

**Safe operating power**



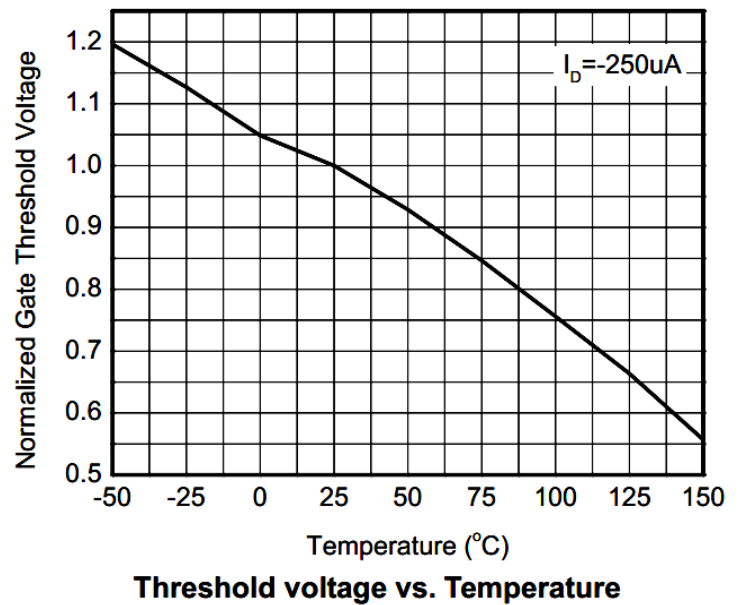
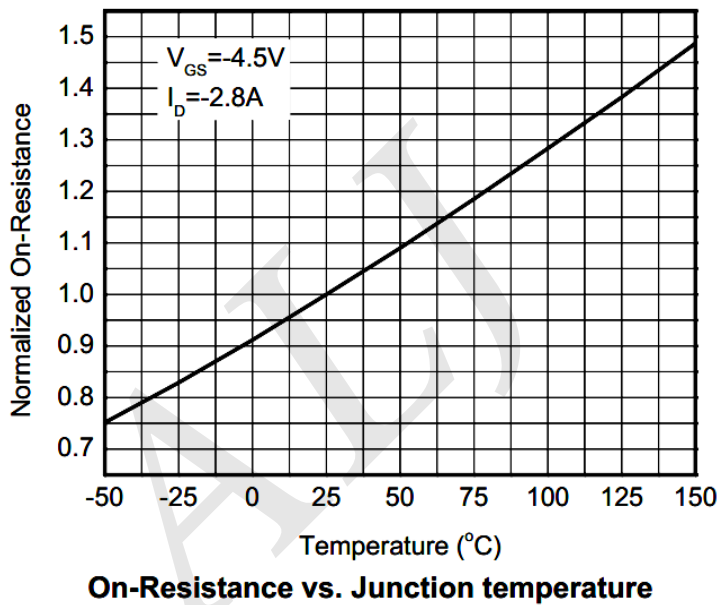
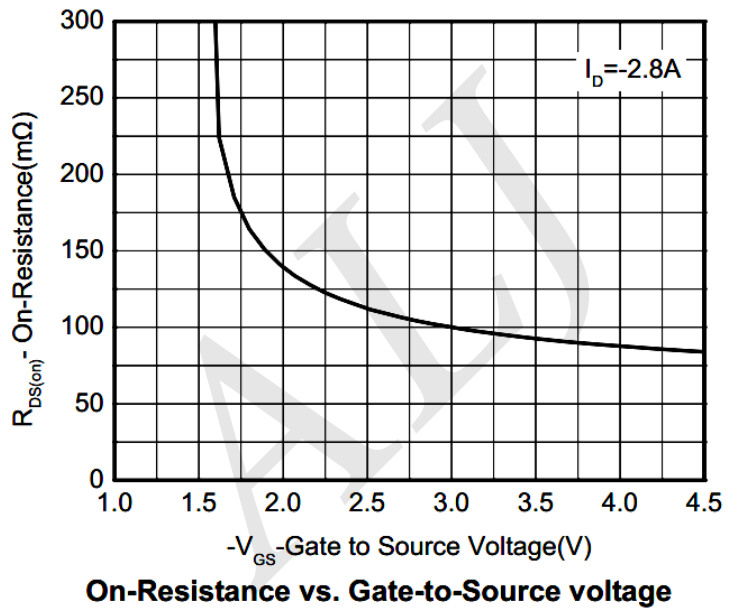
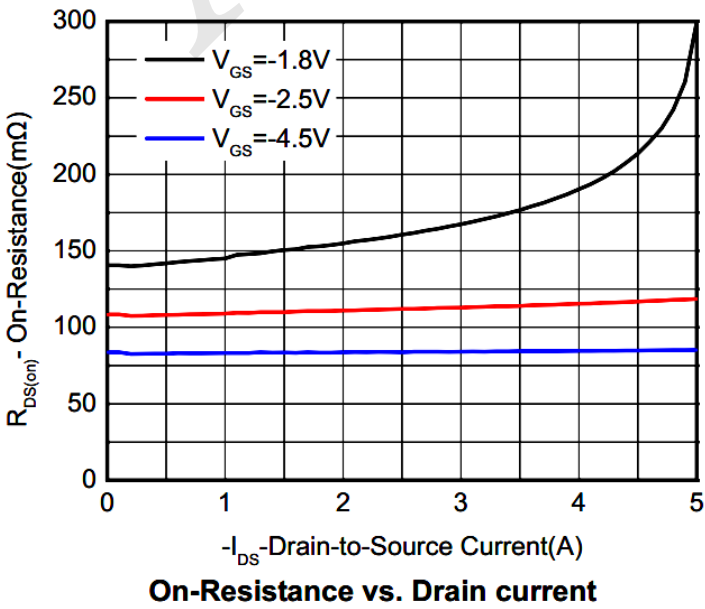
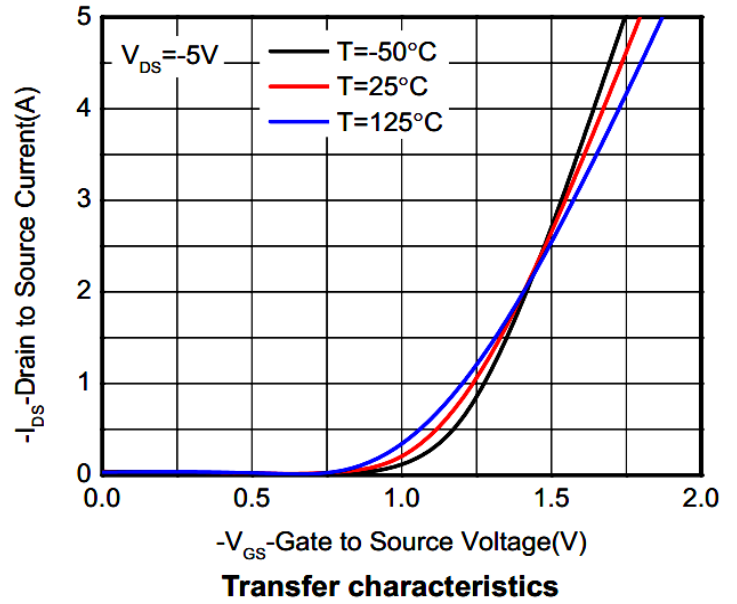
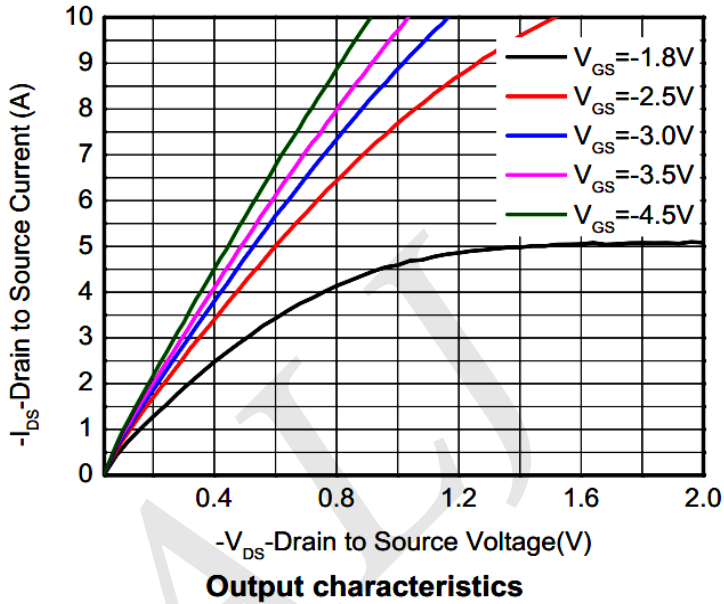
**Gate charge Characteristics**

# N-Channel Typical Characteristics (Cont.)

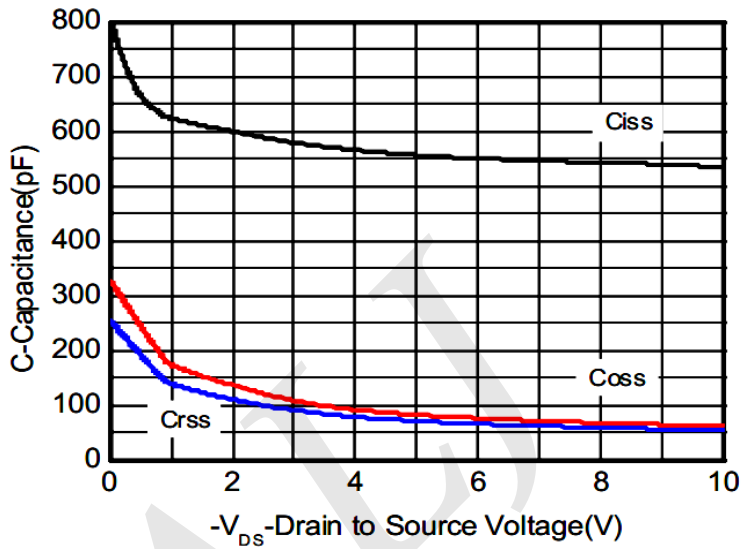


**Transient thermal response (Junction-to-Ambient)**

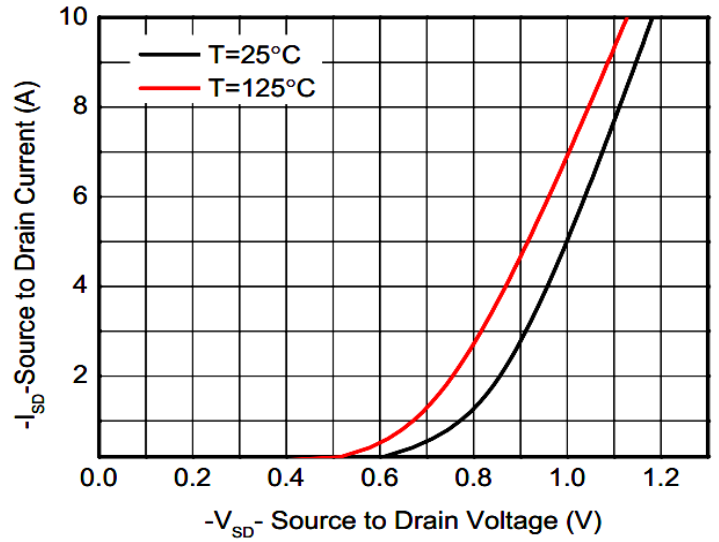
## P-Channel Typical Characteristics (Cont.)



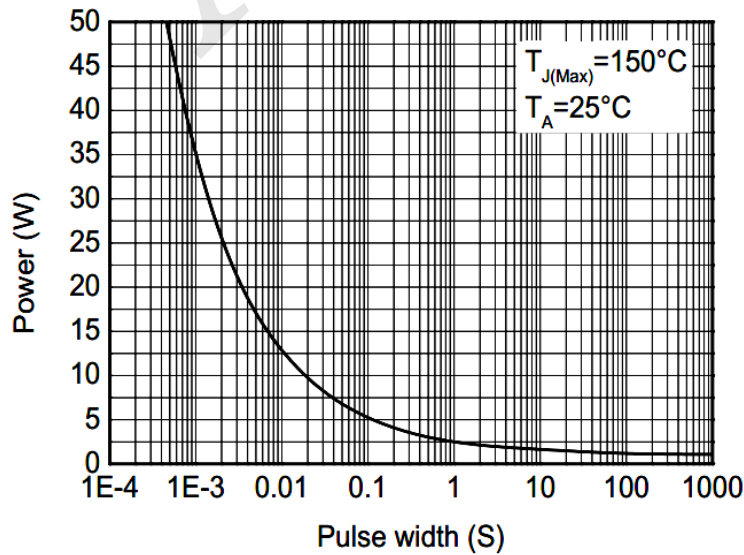
## P-Channel Typical Characteristics (Cont.)



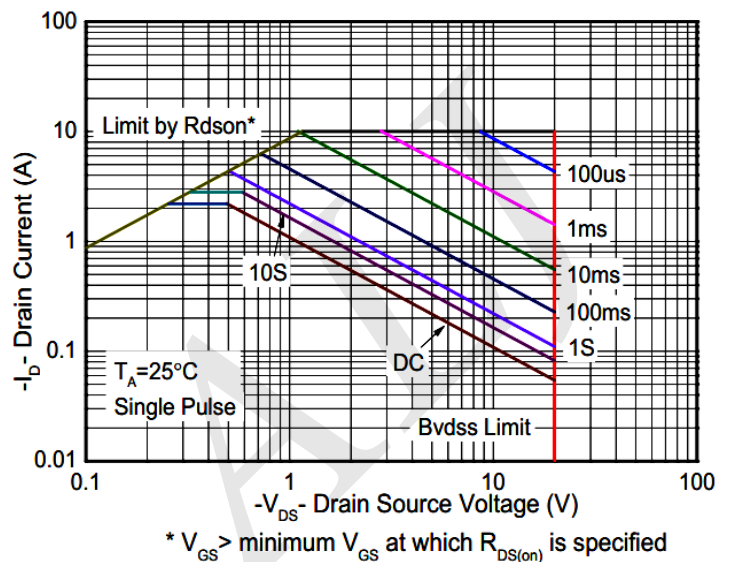
**Capacitor**



**Body diode forward voltage**

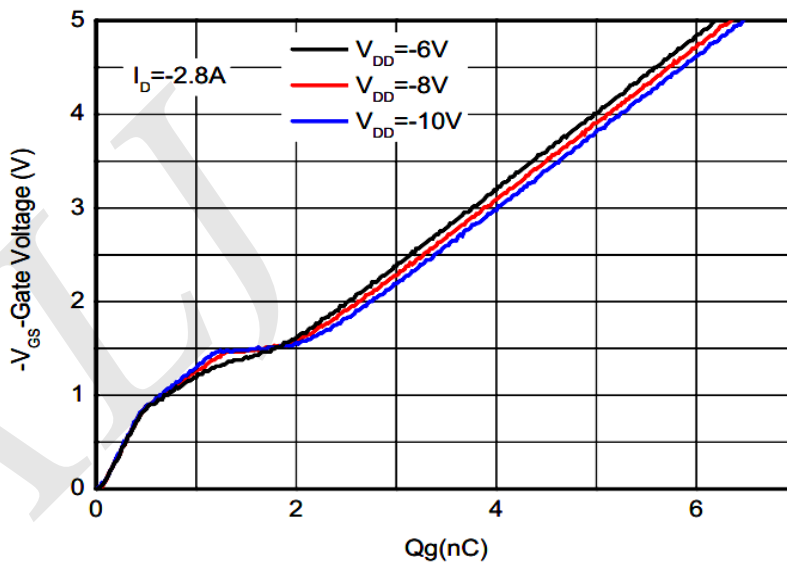


**Single pulse power (Junction-to-ambient)**



\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

**Safe operating power**



**Gate charge Characteristics**

# P-Channel Typical Characteristics (Cont.)

